

RED-EMC Test Report

For

E-Power Limited

Bluetooth speaker

Model No.: 12397700, 12397701, BT502, BT503, BT504, BT505, BT506, BT507, BT508, BT509

Prepared For : Address :

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Date of Test : May 18~29, 2018

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Contents

1. General Information	Yu.		otek A	upo.	be.	4
1.1. Client Information	Anbo		Notek	Anboten	Anbe	4
1.2. Description of Device (EUT)	.4.2	7476. F	W.	-26		4
1.3. Auxiliary Equipment Used During T 1.4. Description of Test Modes 1.5. Test Equipment List	est					4
1.4. Description of Test Modes	Up.	Hotek	Aupore	V _U .		botek
1.5. Test Equipment List	~porc	An.		tek vu	00	6
1.6. Measurement Uncertainty						
1.7. Description of Test Facility	y					
2. Summary of Test Results			opotek	Anbo		8
Summary of Test Results Emission Test Conducted Emission Test at Main Ports	oten An		, potek	Anboic	Am	9
3.1. Conducted Emission Test at Main Ports	Notek	Anbore	VII.	bott	P	9
3.1.1. Test Standard and Limit	". "OFEK	Roboter	Anb		otek	9
3.1.2. Test Setup	Ann	hotek	Anbo	······································	Yay	9
3.1.2. Test Setup	Anbor	ber.	rek	boter	YUD.	10
3.1.4. Test Data	k paboti	Ant.		, botek	Aupor	10
3.2. Radiated Emission Test						15
3.2.1. Test Standard and Limit						15
3.2.2. Test Setup						16
3.2.3. Test Procedure						16
3.2.4. Test Data	, wotek	Anbore	Anu		Notek	<u>An</u> bo
4. Immunity Test	V11.	10d _{11,1}	er An	(b)	Kotek	21
3.2.3. Test Procedure	Ambe	Y	otek	Mpote	Ans	22
4.1.1. Test Standard and Specification	tek Anb	Ora Mi		Kupotek	Anbe	22
4.1.3. Test Procedure	- Nejk	Apoter.	Aupr	- Joseph	دم	22
4.1.3. Test Procedure	//o	Note ^k	Anbore	All	, val	23
4.1.4. Test Data	Anbor	br.	, both	er Aup		23
4.2. Radiated, RF Electromagnetic Fields Test	"apole"	Ann	.v	otek	nbor	24
4.2.1. Test Standard and Specification				- diek	Repoter	24
4.2.2. Test Setup	b),	otek kalo	ooter	Anb	أمىرأ	24
4.2.3. Test Procedure	Ve. VUD	VoV	otek	Aupor	VI.	24
4.2.4. Test Data	botek D	upo	NOTEK	Mpote,	A.T	25
APPENDIX I TEST SETUP PHOTOGRAP	'HH'	Pupote,	Anv	, ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	tek	26
APPENDIX II EXTERNAL PHOTOGRAP	ΥH.	hotek	Anbor	Pri.	WOYEK	28
APPENDIX III INTERNAL PHOTOGRAP	PH Anbo		10.	ote. A	Un.	32





TEST REPORT

Applicant :

Manufacturer :

Product Name : Bluetooth speaker

Model No. 12397700, 12397701, BT502, BT503, BT504, BT505, BT506, BT507, BT508,

BT509

Trade Mark : N.A.

Rating(s) : Input: DC 5V, 350mA (with DC 3.7V, 1200mAh Battery inside)

Test Standard(s) : ETSI EN 301 489-1 V2.2.0 (2017-03)

EN 55032: 2015

EN 55024: 2010+A1: 2015

ETSI EN 301 489-17 V3.2.0 (2017-03)

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the EN 301 489-1, EN 301 489-17, EN 55032 and EN 55024 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test



May 18~29, 2018

Prepared By

(Tested Engineer / Winkey Wang)

Reviewer

(Project Manager / May Lu)

Approved & Authorized Signer

(Manager / Tom Chen)



1. General Information

1.1. Client Information

Applicant	:		P.'	upoto.	And	Anbotek	Anbo	stek by
Address	:			A6"	8.43		7.60	
Manufacturer	:	.07	hotek	Anbo	itek Anbo	Tek VI	nbotek	Anbotek
Address	•	6						oote
								do

1.2. Description of Device (EUT)

Product Name	:	Bluetooth speaker	otek Anbotek Anbotek Ann hotek								
Model No.	:	BT509	Except the model number and housing, so we								
Trade Mark	:	N.A.									
Test Power Supply	:	AC 110V, 50Hz for adapter / AC DC 3.7V Battery inside	230V, 50Hz for adapter								
4		Operation Frequency:	2402~2480MHz								
										Transfer Rate:	1/2 Mbits/s
Product					Number of Channel:	79 Channels					
Description	:	Modulation Type:	GFSK, π/4-DQPSK								
	Antenna Type:		PCB Antenna								
		Antenna Gain(Peak):	1.2 dBi								

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

1.3. Auxiliary Equipment Used During Test

	Adapter	:	Manufacturer: ZTE	otek.	Anbotek	Anbo	hotek
			M/N: STC-A2050I1000USBA-C				And
			S/N: 201202102100876				Anbo
J'C			Input: 100-240V~50/60Hz 0.3A				K A
a l			Output: DC 5V, 1000mA				otek



1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

,	Pretest Mode	Description
P	Mode 1	Charge & BT Mode
	Mode 2	AUX Mode

	For Conducted Emission
Final Test Mode	Description
Mode 1	Charge & BT Mode

	For Radiated Emission
Final Test Mode	Description
Mode 1	Charge & BT Mode
Mode 2	AUX Mode



1.5. Test Equipment List

Conducted Emission Measurement

Ite	em	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
hote	e. 1.	L.I.S.N. Artificial Mains	Rohde & Schwarz	ENV216	100055	Nov. 17, 2017	1 Year
ank	potel	Network					
2	2.,,,,	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year
	3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 17, 2017	1 Year
tok 4	4.	Software Name EZ-EMC	Ferrari Technology	ANB-03A	N/A	N/A	N/A

Radiated Emission Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
$\Psi_{Up_{\mathcal{O}}}$	EMI Test Receiver	Rohde & Schwarz	ESPI NO	101604	Nov. 17, 2017	1 Year
2.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 20, 2017	1 Year
3.	Pre-amplifier	SONOMA	310N	186860	Nov. 17, 2017	1 Year
4.ek	Software Name EZ-EMC	Ferrari Technology	ANB-03A	N/A	N/A	N/A

Electrostatic Discharge Measurement

	Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
otis	1.	ESD Simulators	3Ctest	ESD-30T	ES0131505	Nov. 17, 2017	1 Year

R/S Immunity Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
iek 1	RF Power Meter. Dual Channel	BOONTON	4232A	10539	May 19, 2018	1 year
2	50ohm Diode Power Sensor	BOONTON	51011EMC	34236/36164	May 19, 2018	1 year
An3ote	Broad-Band Horn Antenna	SCHWARZBECK	BBHA9120 L3F	Anbotel 332 Anb	May 19, 2018	1 year
4.00	Power Amplifier (0.08-1G)	MILMEGA	80RF1000-175	1059345	May 19, 2018	1 year
5	Power Amplifier (1-2G)	MILMEGA	AS0102-55	1018770	May 19, 2018	1 year
e¥ 6	Power Amplifier (2-6G)	MILMEGA	AS1860-50	1059346	May 19, 2018	1 year
7	Signal Generator	Agilent	N5181A	MY50145187	May 19, 2018	1 year
8	Field Strength Meter	HOLADAY	HI-6005	N/A	May 19, 2018	1 year
An 90 te	RS232 Fiber Optic Modem	HOLADAY	HI-4413P	N/A	May 19, 2018	1 year
10	LogPer. Antenna	SCHWARZBECK	VULP 9118E	N/A	May 19, 2018	1 year



1.6. Measurement Uncertainty

Radiation Uncertainty	:	Ur = 3.9 dB (Horizontal)
		Ur = 3.8 dB (Vertical)
		Anbotek Anbotek Anbotek Anbotek
Conduction Uncertainty		Uc = 3.4 dB
Disturbance Uncertainty		Ud = 2.6 dB

1.7. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

Test Location

All Emissions tests were performed at

Shenzhen Anbotek Compliance Laboratory Limited.

1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102



2. Summary of Test Results

Anboten Anbo	EMC E	mission	nbotek Anbo	hotek
Γest Items	Standard	Basic Standard	Anboro Ar	Results
Conducted Emission	ETSI EN 301 489-1 V2.2.0 Clause 8.3 & 8.4	EN 55032: 2015	Class A or B NOTE (2)	PASS
Radiated Emission	ETSI EN 301 489-1 V2.2.0 Clause 8.2	EN 55032: 2015	Class A or B NOTE (2)	PASS
Harmonic Current Emission	ETSI EN 301 489-1 V2.2.0 Clause 8.5	EN 61000-3-2:2014	Class A	N/A
Voltage Fluctuations& Flicker	ETSI EN 301 489-1 V2.2.0 Clause 8.6	EN 61000-3-3:2013	ek Appotek	N/A
	EMC Im	munity, bottok		
Test Items	Standard Market Ambot	Basic Standard	Performance Criteria	Results
Electrostatic Discharge	ETSI EN 301 489-1 V2.2.0 Clause 9.3	EN 61000-4-2:2009	В	PASS
RF Electromagnetic Field	ETSI EN 301 489-1 V2.2.0 Clause 9.2	EN 61000-4-3:2006 +A1:2008+A2:2010	A	PASS
Fast transients, common mode	ETSI EN 301 489-1 V2.2.0 Clause 9.4	EN 61000-4-4:2012	otek B Anbor	N/A
Surges	ETSI EN 301 489-1 V2.2.0 Clause 9.8	EN 61000-4-5:2014	Aup B K	N/A
Radio frequency, common mode	ETSI EN 301 489-1 V2.2.0 Clause 9.5	EN 61000-4-6:2014	A	N/A
Volt. Interruptions Volt. Dips	ETSI EN 301 489-1 V2.2.0 Clause 9.7	EN 61000-4-11:2004	B/C/C NOTE (3)	N/A
NOTE:	otek anbotek Anbo	notek hotek	Anbote, Ant	Yek
- 1 / N	test is not applicable in this Te	- A 101	Anboten	Tupe 16K
200	for equipment intended to be tion centre, the class A limits r	DV	industrial envir	conment or
V	0% reduction – Performance C	- '00. by	Aug.	4 ,000
977	0% reduction – Performance C	W 120 D	Jotek Anbou	P.
- CD	% reduction – Performance Cri	16/	abotek Anb	or A
Voltage Interrup	otion: 0% Interruption – Perfor	mance Criteria C	Yu. Jek	nbotek

3. Emission Test

3.1. Conducted Emission Test at Main Ports

3.1.1. Test Standard and Limit

Test Standard	ETSI EN 301 489-1	V2.2.0 Clause	e 8.3 & 8.4	201	A11-	19 ×
Basic Standard	EN 55032: 2015	botek	Anbote	And	Anbotek	Aupo

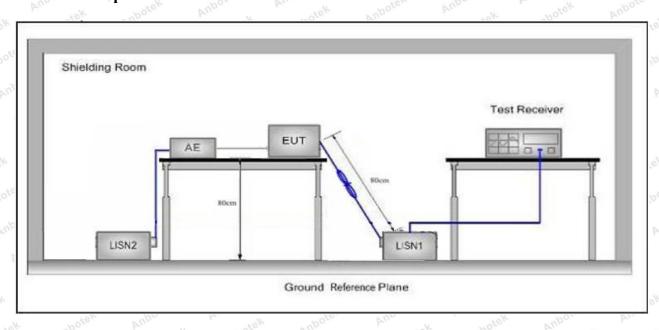
Limits for conducted emissions

	Г	Maximum RF Lin	e Voltage (dBuV)
	Frequency	Quasi-peak Level	Average Level
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *
	500kHz~5MHz	56 stek	46 And 46
	5MHz~30MHz	60 60	P50

Limits for conducted emissions of equipment intended to be used in telecommunication centres and industrial environment

	Emagnamari	Maximum RF Line Voltage (dBuV)					
T4 I ::4	Frequency	Quasi-peak Level	Average Level				
Test Limit	150kHz~500kHz	Anbout 79 Ann hotek	Anboten 66				
S	500kHz~30MHz	Anbote 73 And abotek	Anbotek 60 Anbourtek				

3.1.2. Test Setup





3.1.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to ETSI EN 301 489-1 V2.2.0& EN55032: 2015 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

For the actual test configuration, please refer to the related Item EUT Test Photos.

3.1.4. Test Data

PASS

The EUT should be compliance to the limit of Class B

Only the worst case data was showed in the report, please to see the following pages



Conducted Emission Test Data

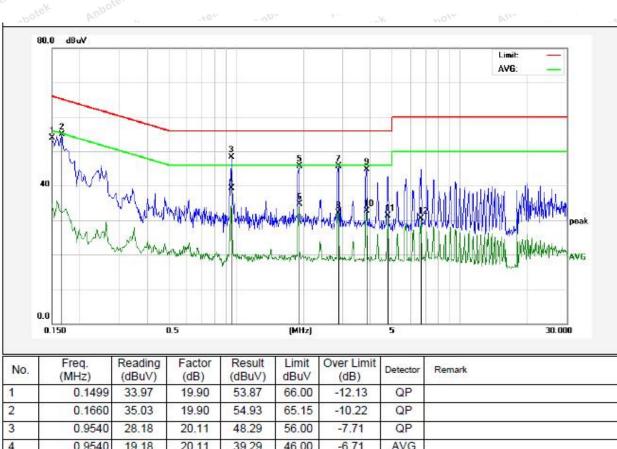
Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification: AC 110V, 50Hz for adapter

Comment: Live Line

Tem.:21.0°C Hum.:56%



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	(dBuV)	Limit dBuV	Over Limit (dB)	Detector	Remark
1	0.1499	33.97	19.90	53.87	66.00	-12.13	QP	
2	0.1660	35.03	19.90	54.93	65.15	-10.22	QP	
3	0.9540	28.18	20.11	48.29	56.00	-7.71	QP	
4	0.9540	19.18	20.11	39.29	46.00	-6.71	AVG	
5	1.9100	25.64	20.14	45.78	56.00	-10.22	QP	
6	1.9100	14.50	20.14	34.64	46.00	-11.36	AVG	
7	2.8620	25.45	20.16	45.61	56.00	-10.39	QP	
8	2.8620	12.04	20.16	32.20	46.00	-13.80	AVG	
9	3.8220	24.49	20.18	44.67	56.00	-11.33	QP	
10	3.8220	12.60	20.18	32.78	46.00	-13.22	AVG	
11	4.7779	11.09	20.20	31.29	46.00	-14.71	AVG	
12	6.6859	10.34	20.25	30.59	50.00	-19.41	AVG	



Conducted Emission Test Data

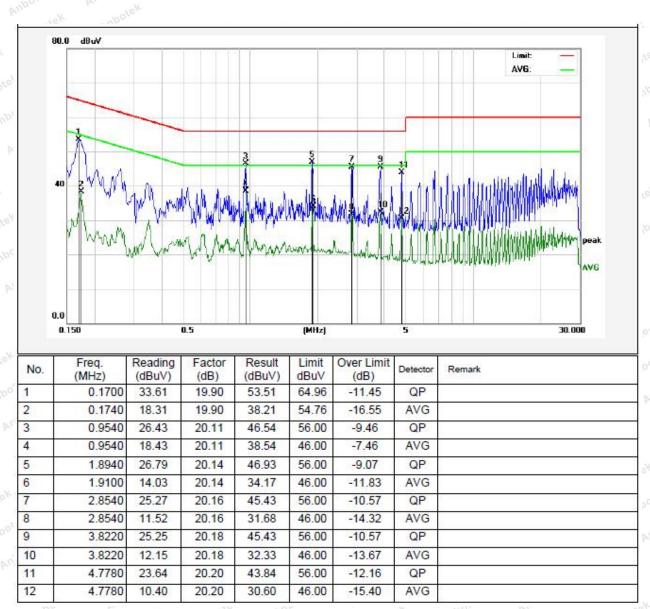
Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification: AC 110V, 50Hz for adapter

Comment: Neutral Line

Tem.:21.0°C Hum.:56%



8

9

10

11

12



Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification: AC 230V, 50Hz for adapter

Comment: Live Line

26.89

13.98

23.57

8.99

23.56

1.9100

1.9100

6.6780

6.6780

7.6340

47.03

34.12

43.82

29.24

43.84

56.00

46.00

60.00

50.00

60.00

20.14

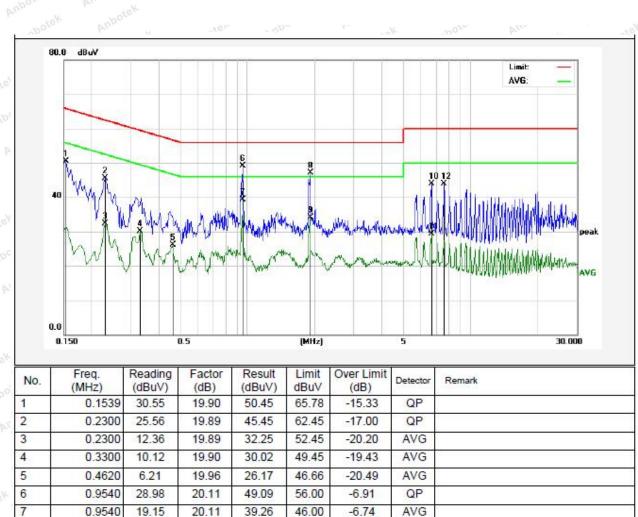
20.14

20.25

20.25

20.28

Tem.:21.0°C Hum.:56%



-8.97

-11.88

-16.18

-20.76

-16.16

QP

AVG

QP

AVG

QP



Conducted Emission Test Data

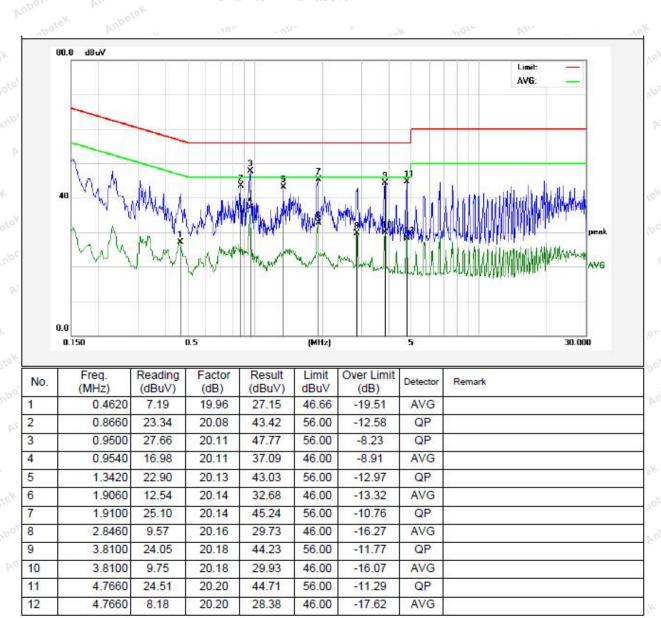
Test Site: 1# Shielded Room

Operating Condition: Mode 1

Test Specification: AC 230V, 50Hz for adapter

Comment: Neutral Line

Tem.:21.0°C Hum.:56%





3.2. Radiated Emission Test

3.2.1. Test Standard and Limit

,10	Test Standard	ETSI EN 301 489-1 V2.2.0 Clause 8.2	Anshotek	Anbotek	Anbotatek	JX.
	Basic Standard	EN 55032: 2015	6.11			

Radiated Emission Test Limit (Below 1000MHz)

	Limit	$(dB\mu V/m)$				
Frequency (MHz)	Quasi-peak Level					
(МПZ)	Class B	Class A				
30MHz~230MHz	ek apotek 40 Anbott	nbot50 Anb				
230MHz~1000MHz	K hotel 47 Anbotes	Anbou				

Radiated Emission Test Limit (Above 1000MHz)

		Limit (c	dBμV/m)				
Frequency (MHz)	Clas	s B	Cla	Class A			
(IVIIIZ)	Peak	Average	Peak	Average			
1000 MHz -3000 MHz	70	50	76	56			
3000 MHz -6000 MHz	Ambore 74 Am	54 botek	80	60			

Radiated Emission Test Limit for FM Receivers

T.	Limit	$(dB\mu V/m)$				
Frequency (MHz)	Quasi-peak Level					
(IVIIIZ)	Fundamental	Harmonics				
30MHz~230MHz	Model Mark	Amboten 52 mb				
230MHz~300MHz	botek 60 bote Amb	Jek Anbotek 52 Anbot Ak				
300MHz~1000MHz	60	56 Anbot				

Frequency Range of Radiated Measurement

Highest frequency generated or Upper frequency of measurement	Range (MHz)
used in the device or on which the device operates or tunes (MHz)	runge (MHZ)
Below 108	1000
108 – 500	2000
500 – 1000	5000
Above 1000	5th harmonic of the highest frequency or 6 GHz, whichever is lower



3.2.2. Test Setup

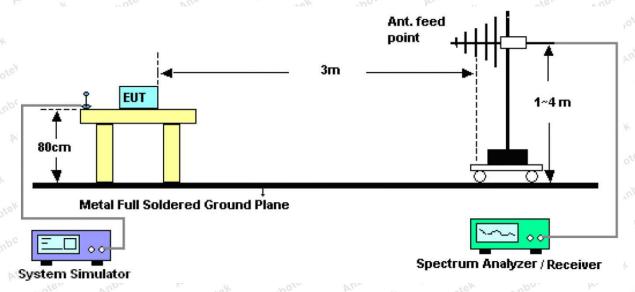


Figure 1. 30MHz to 1GHz

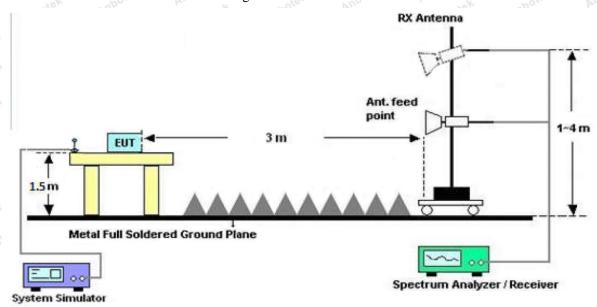


Figure 2. Above 1 GHz

3.2.3. Test Procedure

- 1) The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- 2) The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- 3) The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 4) The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- 5) The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold



mode when the test frequency is below 1GHz.

The test receiver/spectrum was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1GHz.

6) For the actual test configuration, please refer to the related Item -EUT Test Photos.

Note:

The resolution bandwidth of test receiver/spectrum analyzer is 120kHz for Quasi-peak detection (QP) at frequency below 1GHz.

The resolution bandwidth is 1MHz and video bandwidth of test receiver/spectrum analyzer is 3MHz for Peak/Average detection at frequency above 1GHz.

3.2.4. Test Data

PASS

The EUT should be compliance to the limit of Class B

Only the worst case data was showed in the report, please to see the following pages

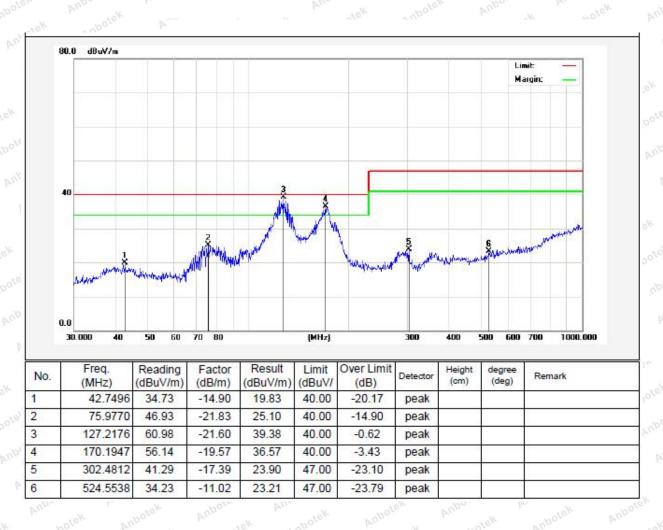


Test Results (30~1000MHz)

Job No.: SZAWW180518011 Temp.(°C)/Hum.(%RH): 23.2°C/54%RH

Standard: EN301489_Class B_3m Power Source: DC 3.7V Battery inside

Test Mode: Mode 2 Polarization: Vertical



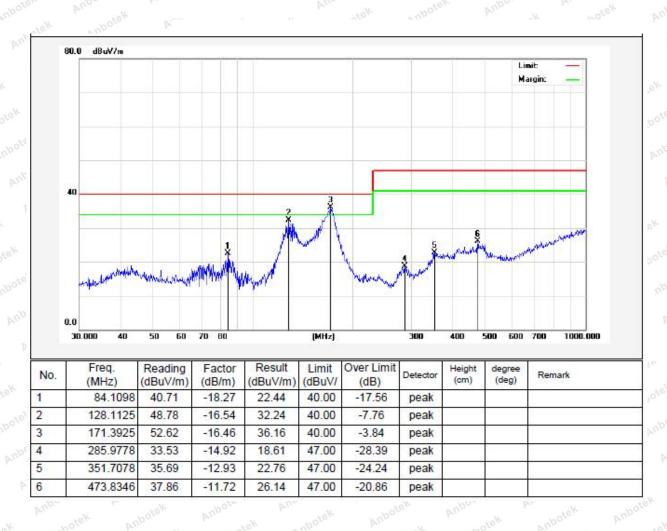


Test Results (30~1000MHz)

Job No.: SZAWW180518011 Temp.(°C)/Hum.(%RH): 23.2°C/54%RH

Standard: EN301489_Class B_3m Power Source: DC 3.7V Battery inside

Test Mode: Mode 2 Polarization: Horizontal





Test Results (1GHz~6GHz)

200	147						
Frequency (MHz)	Read Level (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.	Detector
1596.21	50.84	-2.96	47.88	70.00	-22.12	\mathbf{H}_{por}	PEAK
2135.58	50.17	-2.80	47.37	70.00	-22.63	H Anh	PEAK
2079.60	55.63	-3.66	51.97	70.00	-18.03	-₩ Н	PEAK
3985.38	48.58	-5.37	43.21	74.00	-30.79	Н	PEAK
4674.07	55.53	-4.52	51.01	74.00	-22.99	Hek	PEAK
4999.71	53.19	-5.40	47.79	74.00	-26.21	Н	PEAK
1596.21	41.97	-2.96	39.01	50.00	-10.99	Н	AVG
2135.58	44.95	-2.80	42.16	50.00	-7.84	ek H	AVG
2079.60	37.58	-3.66	33.92	50.00	-16.08	Н	AVG
3985.38	42.66	-5.37	37.28	54.00	-16.72	H	AVG
4674.07	43.89	-4.52	39.38	54.00	-14.62	Anbote	AVG
4999.71	41.64	-5.40	36.24	54.00	-17.76	PHOOFE	AVG
1329.16	46.47	-2.32	44.16	70.00	-25.84	VAnb	PEAK
2080.34	47.64	-2.82	44.82	70.00	-25.18	V	PEAK
2142.39	47.99	-3.89	44.10	70.00	-25.90	V	PEAK
3974.68	51.65	-4.45	47.20	74.00	-26.80	V	PEAK
4387.32	48.30	-5.07	43.23	74.00	-30.77	Votek	PEAK
5041.62	55.68	-5.38	50.30	74.00	-23.70	V	PEAK
1329.16	37.74	-2.32	35.42	50.00	-14.58	V	AVG
2080.34	39.17	-2.82 kn ^{bs}	36.36	50.00	-13.64	V	AVG
2142.39	38.42	-3.89	34.53	50.00	-15.47	V	AVG
3974.68	42.77	-4.45	38.32	54.00	-15.68	Anbote V	AVG
4387.32	39.25	-5.07	34.18	54.00	-19.82	V	AVG
5041.62	42.47	-5.38	37.09	54.00	-16.91	Vanbo	AVG

Remark:

1. Level =Receiver Read level + Antenna Factor

4. Immunity Test

General Performance Criteria

◆ Performance criteria for continuous phenomena applied to transmitters and receivers (CT/CR)

During and after the test, the apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by themanufacturer when the apparatus is used as intended. In some cases this permissible performancelevel may be replaced by a permissible loss of performance.

During the test the EUT shall not unintentionally transmit or change its actual operating state andstored data.

If the minimum performance level or the permissible performance loss is not specified by themanufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.

◆ Performance criteria for transient phenomena applied to transmitters and receivers (TT/TR)

After the test, the apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by the manufacturer, when the apparatus is used as intended. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the EMC exposure to an electromagnetic phenomenon, a degradation of performance is, however, allowed. No change of the actual mode of operation (e.g. unintended transmission) orstored data is allowed.

If the minimum performance level or the permissible performance loss is not specified by themanufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the apparatus if used as intended.

◆ Performance criteria for equipment which does not provide a continuous communication link

For radio equipment which does not provide a continuous communication link, the performancecriteria described in CT/CR and TT/TR are not appropriate, then the manufacturer shall declare, forinclusion in the test report, his own specification for an acceptable level of performance ordegradation of performance during and/or after the immunity tests.

The performance criteria specified by the manufacturer shall give the same degree of immunityprotection as called for in CT/CR and TT/TR.

◆ Performance criteria for ancillary equipment tested on a stand alone basis

If ancillary equipment is intended to be tested on a stand alone basis, the performance criteriadescribed in CT/CR and TT/TR are not appropriate, then the manufacturer shall declare, for inclusionin the test report, his own specification for an acceptable level of performance or degradation of performance during and/or after the immunity tests.

The performance criteria specified by the manufacturer shall give the same degree of immunityprotection as called for in CT/CR and TT/TR.

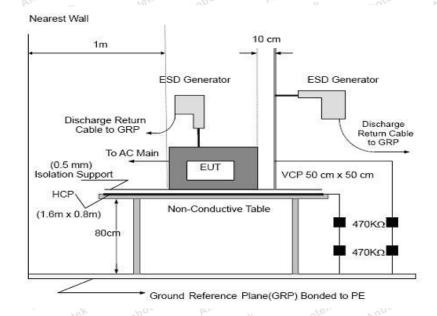


4.1. Electrostatic Discharge Test

4.1.1. Test Standard and Specification

Pr. V	ok no Air at a ser at
Test Standard	ETSI EN 301 489-1 V2.2.0 Clause 9.3
Basic Standard	EN 61000-4-2:2009
Discharge Impedance:	330 ohm / 150 pF
Performance Criterion:	CT/CR And Andrew Andrew Andrew Andrew Andrew
Discharge Voltage:	Air Discharge: 2kV/4kV/8kV
Polarity:	Positive & Negative
Number of Discharge:	Air Discharge: min. 20 times at each test point
Discharge Mode:	Single Discharge
Discharge Period:	1 second minimum

4.1.2. Test Setup



Note:

TABLE-TOP EQUIPMENT:

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940kohm total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC /EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

FLOOR-STANDING EQUIPMENT:

The equipment under test was installed in a representative system as described in section 7 of IEC/EN 61000-4-2,



and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

4.1.3. Test Procedure

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

1) Contact discharge was applied to conductive surfaces and coupling planes of the EUT.

During the test, it was performed with single discharges. For the single discharge timebetween successive single discharges was at least 1 second.

Vertical Coupling Plane (VCP):

The coupling plane, of dimensions $0.5m \times 0.5m$, is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge

Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

2) Air discharges at insulation surfaces of the EUT.

It was at least ten single discharges with positive and negative at the same selected point.

3) For the actual test configuration, please refer to the related Item –EUT Test Photos.

4.1.4. Test Data

Job No.: SZAWW180518011 Temp.(℃)/Hum.(%RH): 23.2℃/54%RH

Standard: EN61000-4-2 Power Source: AC 230V, 50Hz for adapter /

DC 3.7V Battery inside

Test Mode: Mode 1, Mode 2

Item	Contact Discharge to couple	Air Discharge at insulating surfaces			
Anbo	Direct Contact Discharge	Indirect Contact Discharge	Surfaces		
Test Voltage	Reaction of EUT / Result	Reaction of EUT / Result	Reaction of EUT / Result		
+2kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS		
-2kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS		
+4kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS		
-4kV	n.r.r. PASS	n.r.r. PASS	n.r.r. PASS		
+6kV	And tek - nbotek	Anbote K An otek	n.r.r. PASS		
-6kV	Anbo. ok hotek	Anbore - Anb	n.r.r. PASS		
+8kV	ek Anbore Ans	K Anbotek Anbox	n.r.r. PASS		
-8kV	notek Anbotek Anbo	tek shotek Anbote	n.r.r. PASS		

Remarks: n.r.r. = no reaction recognized

Performance Criteria A observed and No any function degraded during the tests.

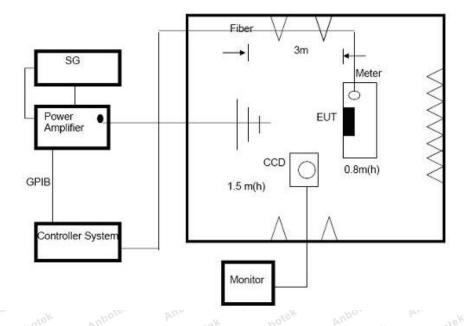


4.2. Radiated, RF Electromagnetic Fields Test

4.2.1. Test Standard and Specification

N. V.	OK HOLL ALL
Test Standard	ETSI EN 301 489-1 V2.2.0 Clause 9.2
Basic Standard	EN 61000-4-3: 2006+A1:2008+A2:2010
Required Performance	A ter to k bor Am
Frequency Range	80MHz to 6GHz
Field Strength	3 V/m
Modulation	1kHz Sine Wave, 80%, AM Modulation
Frequency Step	1 % of preceding frequency value
Polarity of Antenna	Horizontal and Vertical
Test Distance	3 minbod tek Anbotek Anbotek Anbotek Anbotek Anbotek
Antenna Height	1.5 m Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek
Dwell Time	at least 3 seconds
Vie Vii.	rest of the second seco

4.2.2. Test Setup



4.2.3. Test Procedure

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber. The testing distance from antenna to the EUT was 3 meters.

- 1) The field strength level was 3V/m
- 2) The frequency range is swept from 80 MHz to 6000 MHz with the signal 80%amplitude modulated with a 1kHz sine wave.
- 3) The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond, but shall in no case be less than 0.5s.



4) The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

4.2.4. Test Data

Job No.: SZAWW180518011 Temp.(°C)/Hum.(%RH): 23.2°C/54%RH

Standard: EN61000-4-3 Power Source: AC 230V, 50Hz for adapter /

DC 3.7V Battery inside

Test Mode: Mode 1, Mode 2

1		VUP	You	-10° V		181	
0	Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Observation	Perform. Criteria	Results
0	Anbotek Ant	otek An	Dotek Anbote	Front	ek Anbotek	Anbotek Anbotek	Anbotek
1	80~6000	H/V	3 V/m (rms) AM Modulated	Rear	CT,CR	otek A Anb	PASS
00		K VL	1000Hz, 80%	Left			
Α.	hbotek Anbote	otek	de. Mr.	Right	N 107	D22.	



APPENDIX I -- TEST SETUP PHOTOGRAPH

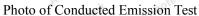




Photo of Radiation Emission Test

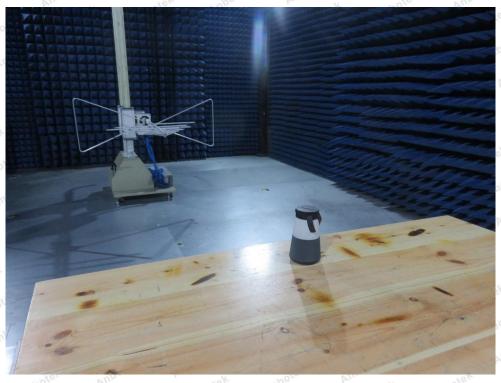




Photo of Electrostatic Discharge Test

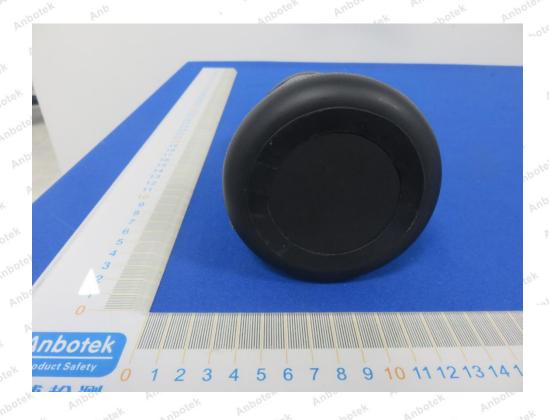


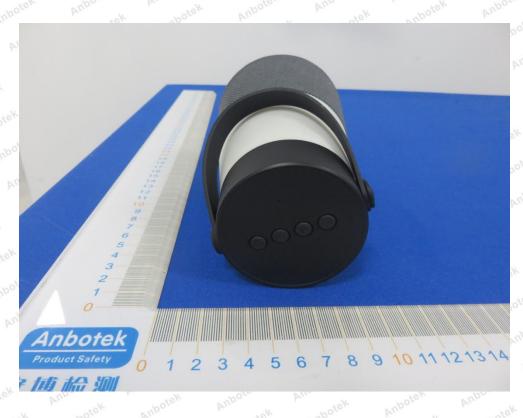
Photo of RF Field Strength Susceptibility Test



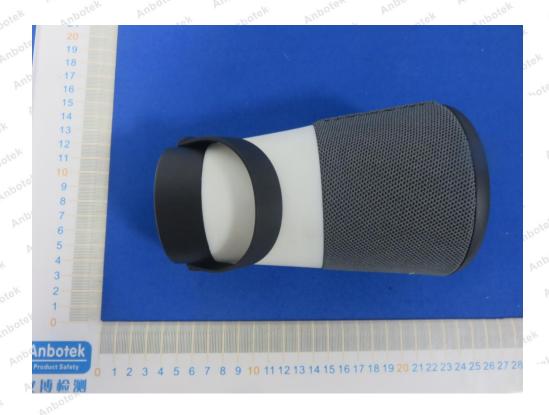


APPENDIX II -- EXTERNAL PHOTOGRAPH















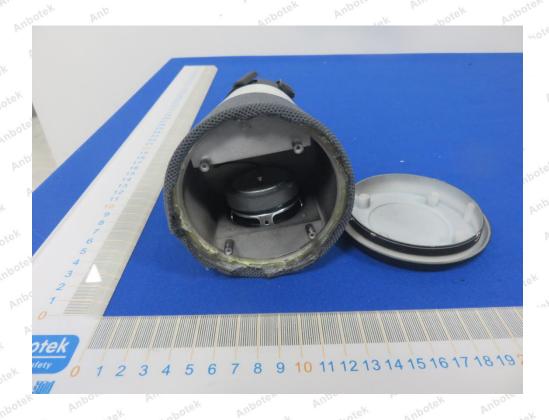






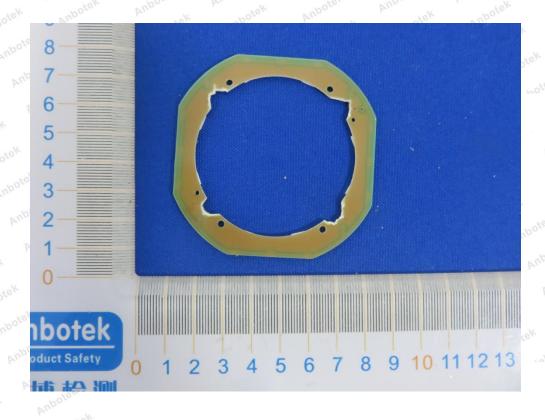


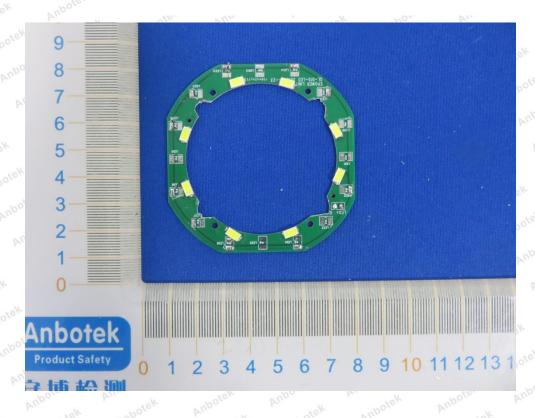
APPENDIX III -- INTERNAL PHOTOGRAPH



























---- End of Report-----